

| FORM PTO 1449 (modified)<br>U.S. DEPARTMENT OF COMMERCE<br>PATENT AND TRADEMARK OFFICE |                      |   | ATTY DOCKET NO.<br><b>03500.014529.1</b>  | APPLICATION NO.<br><b>Unassigned (Divisional of Appln. No. 09/586,887, filed June 5, 2000)</b> |                            |          |                                 |
|--|----------------------|---|---|--|----------------------------|----------|---------------------------------|
| LIST OF REFERENCES CITED BY APPLICANT(S)<br>(Use several sheets if necessary)          |                      |   | APPLICANT<br><b>Yukiko IWASAKI ET AL.</b> |  |                            |          |                                 |
| Date Submitted: September 24, 2003   |                      |   | FILING DATE<br><b>September 24, 2003</b>  |  | PRIOR GROUP<br><b>2822</b> |          |                                 |
| U.S. PATENT DOCUMENTS  |                      |   |   |  |                            |          |                                 |
| *EXAMINER INITIAL  |                      | DOCUMENT NUMBER   | DATE                                      | NAME   | CLASS                      | SUBCLASS | FILING DATE IF APPROPRIATE      |
| SDI  |                      | <b>5,856,229</b>  | <b>01/1999</b>                            | <b>Sakaguchi, et al.</b>   |                            |          |                                 |
|  |                      | <b>5,811,348</b>  | <b>09/1998</b>                            | <b>Matsushita, et al.</b>  |                            |          |                                 |
|  |                      | <b>6,190,937</b>  | <b>02/2001</b>                            | <b>Nakagawa, et al.</b>  |                            |          |                                 |
|  |                      | <b>6,221,738</b>  | <b>04/2001</b>                            | <b>Sakaguchi, et al.</b>   |                            |          |                                 |
|  |                      | <b>6,382,292</b>  | <b>05/2002</b>                            | <b>Ohmi, et al.</b>  |                            |          |                                 |
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|  |                      | DOCUMENT NUMBER   | DATE                                      | COUNTRY  | CLASS                      | SUBCLASS | TRANSLATION YES/NO/ OR ABSTRACT |
|  |                      | <b>8-213645</b>   | <b>08/1996</b>                            | <b>Japan</b>   |                            |          | <b>abstract</b>                 |
|  |                      | <b>7-302889</b>   | <b>11/1995</b>                            | <b>Japan</b>   |                            |          | <b>abstract</b>                 |
|  |                      | <b>10-190032</b>  | <b>07/1998</b>                            | <b>Japan</b>   |                            |          | <b>abstract</b>                 |
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| EXAMINER   | <i>Shanetta Kase</i> |   | DATE CONSIDERED                           |  | <i>3/17/04</i>             |          |                                 |

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| FORM PTO 1449 (modified)<br>U.S. DEPARTMENT OF COMMERCE<br>PATENT AND TRADEMARK OFFICE |  |                  | ATTY DOCKET NO.<br><b>03500.014529.1</b>  | APPLICATION NO.<br><b>Unassigned (Divisional of Appln. No. 09/586,887, filed June 5, 2000)</b> |                |          |                                 |
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| *EXAMINER INITIAL  |  | DOCUMENT NUMBER  | DATE                                      | NAME   | CLASS          | SUBCLASS | FILING DATE IF APPROPRIATE      |
| <i>SDI</i>   |  | <b>6,613,678</b> | <b>09/2003</b>                            | <b>Sakaguchi, et al.</b>   |                |          |                                 |
|  |  | <b>6,391,743</b> | <b>05/2002</b>                            | <b>Iwane, et al.</b>   |                |          |                                 |
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|  |  | DOCUMENT NUMBER  | DATE                                      | COUNTRY  | CLASS          | SUBCLASS | TRANSLATION YES/NO/ OR ABSTRACT |
|  |  | <b>0989616</b>   | <b>03/2000</b>                            | <b>Europe</b>  |                |          |                                 |
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| OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)               |  |                  |   |  |                |          |                                 |
| EXAMINER   |  |                  |   | DATE CONSIDERED  | <i>3/17/04</i> |          |                                 |

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